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4. PERFORMING ORGANIZATION REPORT NUMBER(S)					5. MONITORING ORGANIZATION REPORT NO 188 (S)					
Stanford University				6b. OFFICE SYMBOL (If applicable)	Department of the Navy					
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W.W.	d L. Ginz Hansen La ord, CA 9	aborator	ies of P	hysics	Arlington, Virginia 22217-5000					
88. NAME OF FUNDING/SPONSORING ORGANIZATION				8b. OFFICE SYMBOL (If applicable)	9. PROCUREMENT INSTRUMENT IDENTIFICATION NUMBER \$100014-83-K-0391					
8c. ADDRE	PRESS (City, State and ZIP Code) 10. SOURCE OF FUNDING NOS.									
					PROGRAM ELEMENT NO.	PROJECT NO.	TASK NO.	WORK UNIT		
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ELECTRICAL TRANSPORT THROUGH TUNNEL BARRIERS AND THIN DIELECTRIC LAYERS AND PHYSICAL PROPERTIES OF THE HIGH Tc OXIDE SUPERCONDUCTORS

Final Report for the Period April 1, 1983—September 30, 1989

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Sponsored by the Office of Naval Research under Contract No. N00014-83-K-0391

March 1990

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ELECTRICAL TRANSPORT THROUGH TUNNEL BARRIERS AND THIN DIELECTRIC LAYERS AND PHYSICAL PROPERTIES OF THE HIGH Tc OXIDE SUPERCONDUCTORS

I. Introduction and Summary of Research Completed

In broad terms the research supported under this contract was aimed at the study of advanced superconducting electronic materials, tunneling studies of these materials and studies of the tunneling process itself. It also involved the development and use of advance vapor deposition techniques to synthesize superconducting materials in thin film form and to create artificial (and artificially structured) barriers in superconducting tunnel junctions and other types of Josephson junctions.

Historically, there were four basic elements in the program. The first was the development of approaches and procedures for forming superconductive tunnel junctions on the (then) high transition temperature superconductors of the A15 class, and the study of the characteristics of these devices from both the practical and fundamental points of view. This work led to a general approach for forming tunnel junctions on materials with poor native oxides through the use of ultra-thin, deposited amorphous silicon (a-Si) layers that were subsequently oxidized. These deposited barriers were found to be widely applicable—a kind of generic tunnel barrier material—and opened up the field of tunneling studies of the A15 and many other superconductors by ourselves and other groups. As part of this program, we applied these barriers to tunneling studies of Nb₃Sn and V₃Ga—two important A15 superconductors. The work clarified the origins of the high transition temperatures of these two superconductors and, in particular, the importance of disorder in the reduction of Tc as their composition deviated from the ideal 3:1 stoichiometry.

The second element was a comprehensive study of electronic transport through tunnel barriers containing localized states. This work was an outgrowth of our development of a-Si tunnel barriers described above. Amorphous silicon is known to contain a high density of localized states. By using various forms of our deposited amorphous silicon barriers, we were able to

study transport via such localized states as a function of their density, of their location in the barrier, and of the thickness of the barrier. Ultimately we learned how to deposit pin-hole-free, pure a-Si barriers with no oxide. These various a-Si barriers turned out to be an effective model system for studying the effects of localized states on the tunneling process. The results have led to an increasingly thorough understanding of the role of localized states on tunneling, their relation to resonant tunneling and how they lead to a deterioration of superconductive tunneling device characteristics. The results of this work are also relevant to transport in mesoscopic systems (e.g., one-dimensional MOSFETS). It has stimulated a sizeable amount of theoretical work that has played a crucial role in interpreting the data.

The third element of our program was the study of transport through barriers formed from materials near a continuous insulator/metal transition. The material system employed was an amorphous Nb-Si alloy. This alloy undergoes an insulator/metal transition at about 11% Nb. The goal was to understand transport at short length scales in materials exhibiting electronic localization, and to investigate potential device applications. By incorporating barriers just on the metal side of the insulator/metal transition, we were able to form for the first time sandwich-type superconducting/normal/superconducting (SNS) Josephson devices with usefully high resistances (e.g. ohms). Previous sandwich-type SNS junctions were made using elemental normal metal barriers (e.g., copper or gold) and had exceedingly low resistances. Our high resistance SNS sandwich-type device is an attractive alternative to the traditional resistively shunted tunnel junctions for applications where nonhysteretic I-V characteristic are required. Our device is much more compact and more easily fabricated than the shunted tunnel junctions. It also may have better performance.

These studies of tunneling via localized states, and the nature of the transport in barriers near an insulator/metal transition, may be of relevance for recent work aimed at forming tunneling or Josephson junction devices with the new high temperature oxide superconductors. The most obvious examples are the attempts to use PrBa₂Cu₃O₇ as a barrier in sandwich-type YBa₂Cu₃O₇/PrBa₂Cu₃O₇/YBa₂Cu₃O₇ tunnel junctions. Transport in the insulating phases of these oxide superconductors is thought to occur via variable range hopping, and

therefore localized states are implicated. We expect that this work may also have relevance for the conductivity and breakdown of thin insulating layers in integrated circuits.

The fourth element of this program was a response to the discovery of superconductivity at very high temperatures by Bednorz and Mueller. Since that astonishing event, we have included studies of these remarkable new superconductors in our work. It represents a natural extension of our previous program. In collaboration with our colleagues at Stanford (Geballe, Kapitulnik and Hammond), we developed the first successful approach to the deposition of these new superconductors in thin films form and have studied the properties of the resultant films from various points of view. Among the highlights of this work were the first synthesis of these materials in thin film form, development of the post-annealed process for film synthesis, the first detailed study of the materials science of post-annealed films, the first demonstration of the high current carrying capacity of these superconductors, and tunneling studies using point contacts and sandwich-type junctions that first suggested and continue to suggest anomalously large energy gaps in these superconductors. In collaboration with the groups of John Clarke and Paul Richards at the University of California at Berkeley, we have also studied the noise processes in these films and established the dependence of this noise on the microstructure of the films. Finally, more recently we have explored the potential of electron beam reactive evaporation for the in situ growth of YBa₂Cu₃O₇. A useful summary of this work, along with that of other workers in the field, can be found in the review article prepared under this program for inclusion in the recent Special Issue of the Proceedings of the IEEE on Superconductivity.

In the remainder of this report, we discuss in turn each of these accomplishments in greater detail. Detailed references are included for the reader seeking additional detail. A list of all publications prepared under this contract is included in Appendix A.

II. Tunnel Junctions and Tunneling into the A15 Superconductors.

Superconductive tunnel junctions are important in both the electronic applications of superconductivity and as a remarkably effective probe of the

microscopic aspects of superconductivity. Traditionally, tunnel junctions could only be made on those superconductors for which the native oxide formed a good tunnel barrier. Unfortunately, useful barriers do not form naturally on the surface of most currently interesting superconducting materials. As we had shown in a previous ONR program, oxidized, deposited amorphous silicon (a-Si) barriers can be used to form tunnel barriers on a wide variety of sensitive materials in which the barrier properties are largely independent of the base material [1]. The idea is that the oxidized silicon (SiOx), which actually forms the barrier, is separated from the surface of the material by an unoxidized layer of amorphous silicon. This a-Si layer serves to protect the underlying metal.

In the work supported by this program, this oxidized a-Si barrier was systematically applied to tunneling studies of Nb₃Sn [2,3,4] and V₃Ga [4,5,6]. A second essential part of this work was the development of deposition procedures necessary to grow thin films of these superconductors suitable for tunneling studies and device applications.

In the case of Nb₃Sn, we were able using electron-beam coevaporation to fabricate and study tunnel junctions over a wide range of Nb and Sn concentrations. Thus it was possible to study how the superconducting parameters of this materials evolved as one approached the ideal 3:1 stoichiometric material as the Sn concentration was increased. In particular, it was possible to study how the electron-phonon spectral function $\alpha^2F(\omega)$, which can be derived from the tunneling I-V characteristic and which is the quantity that most clearly reveals the microscopic origins of the superconductivity, evolved as a function of composition. The thin film deposition procedures and junction fabrication techniques developed are described in detail in Refs. 2 and 4. The detailed study of the electron-phonon spectral function is described in Refs. 3 and 4.

Our essential result is that as the 3:1 stoichiometric composition is approached, the spectral weight of the electron-phonon interaction shifts to lower frequencies and increases overall in strength. The net result is an increase in the electron-phonon interaction parameter. At the same time, the Coulomb repulsion μ^* is constant. These results reveal in microscopic terms why Tc increases as stoichiometry is approached. At a deeper level they show that it is

changes in the electron-phonon interaction, and not the electron-electron Coulomb interactions, that governs the systematics of Tc, and that mode softening alone is not enough to account for the increase in Tc as stoichiometry is approached. There must also be an overall increase in the density of states.

The case of V₃Ga is even more illuminating, since the A15 phase exists on both sides of stoichiometry. By studying the variation of Tc and and the transport properties of the Va-Ga system as we varied the composition through the 3:1 stoichiometry, we found that the most natural variable seemed to be resistivity, not the composition. More specifically, we found that the depression of Tc in off-stoichiometric material was a universal function of the resistivity, independent of the composition. This result strongly suggests that the Tc reduction is largely due to disorder and only secondarily to changes in electron density. Combining these observations with those we obtained on Nb₃Sn, we conclude that the reduction of Tc in off-stoichiometric A15 superconductors must be due primarily to the reduction of the peak in the electronic density of states near the fermi level brought on as a result of disorder. We also examined the electron-phonon spectral function for this material in order to establish whether phonon softening as observed in Nb₃Sn was also present in V₃Ga. These results are described in Refs. 5, 6 and 7.

Finally, in the case of V₃Ga we were able observe a splitting of the superconducting tunneling density of states in the presence of a high magnetic field—essentially a Zeeman splitting of the quasiparticle states in the superconductor. This represented the first observation of this effect in an A15 superconductor and confirmed that the Cooper pairs are in the usual singlet spin state. The effect would be absent in the case of triplet pairing and is smeared out in materials with strong spin-orbit scattering. V₃Ga was a particularly attractive material for this study because it is formed from low-Z elements and therefore has little spin-orbit scattering. It would be of considerable interest to repeat this experiment on the high Tc oxide superconductors, where the relevant constituent elements (Cu and O) have even lower Z's. These results are described in Refs. 6 and 7.

III. Transport Via Localized States in Tunnel Barriers

Transport via localized states in tunnel barriers is an oft quoted source of various non-idealities in superconductive tunnel junctions, e.g., excess conductance below the superconducting energy gap and reduction of the Josephson tunneling current. Since no good understanding of the effects of such processes was available, localized states became a "rug" under which many unexplained tunneling anomalies have become swept.

In a series of studies using variants of our a-Si barrier, various barrier configurations (a-Si/SiOx bilayers, SiOx/a-Si/SiOx trilayers, SiOx/a-Si:H/SiOx trilayers and pure a-Si monolayers) were produced and used to separate the direct tunneling processes from those involving localized states and to establish conditions in which transport via the localized states dominate the total tunneling current [7,8,9]. Also, by making micron-sized junctions, we were able to observe the contributions of individual localized states in the overall I-V curve [9]. With such small junctions it was possible to measure the energy dependence of the transmission via an individual localized state. We also studied the 1/f resistance fluctuations in these junctions associated with the localized states [10].

Among our principal observations were that:

- (1) as expected theoretically, localized states contribute most when they are located at the electrical center of a barrier (i.e., when they are located where the tunneling probability to the two metal electrodes is equal) [7,9];
- (2) as also expected theoretically, the dominant tunneling mechanism crosses over from direct tunneling to tunneling via localized states as the thickness of the tunnel barrier increases [7,8,9];
- (3) in submicron junctions it is possible to isolate the conductance due to individual localized states, and the energy width of the transmission of these individual localized states is wider than that expected on the basis of the simplest theories of elastic (energy conserving) resonant tunneling. The width is also

temperature dependent, which suggests that inelastic processes are operative [7,9];

- (4) tunnel barriers containing localized state exhibit very nonlinear I-V characteristics. This nonlinearity grows as the junctions are made thicker and the relative contribution of tunneling via the localized state increases. Previous workers attributed this nonlinearity to a low barrier height in a-Si (as small as 30 meV) [7,11]. Our results show that this interpretation is not correct and that the nonlinearity is due to the transport process via the localized states themselves [12]. Recently a theory of this nonlinearity, motivated by our observations, was presented that accounts for this nonlinearity in terms of sequential hopping via increasingly long chains of localized states as the bias voltage increases [13]. This process is the precursor of the variable range hopping process that governs electrical transport in bulk a-Si. Elaborations of the theory also predict a host of other phenomena that should be observable with our a-Si barriers. These include correlated tunneling process due to coulomb interactions that prevent multiple occupancy of the localized states during the tunneling process, and a Kondo resonance-related anomaly near zero bias. The latter effect results from an interaction of the conduction electrons in the electrodes with the spin of the electrons occupying the localized states.
- (5) transport via localized state appears to be suppressed for now bias voltages over a voltage range that depends on the barrier thickness. There is no clear interpretation of this effect at the present time [11].

In addition to the results enumerated above, we also carried out studies of how the superconductive tunneling characteristic of Nb/a-Si/Nb tunnel junctions deteriorated as the contribution of tunneling via localized states was increased. The existence of these results has also stimulated recent theoretical work [14]. Most interesting are predictions of enhanced Josephson currents, nonsinusoidal current phase relations and even a prediction that $I = -I_0 \sin \vartheta$ under certain conditions!

From the above it should be clear that the physics of tunneling via localized state is richer than even we imagined when we began this program.

IV. Barriers Formed from Materials Near an Insulator/Metal Transition.

Transport in materials near a continuous insulator/metal transition has been the subject of intense interest. It is known that electrons become localized in such systems due simply to disorder. The role of Coulomb interactions introduces new elements to the problem that are much less well understood. In our program, we have focused on the behavior at short length scales where the conductance is length dependent.

The material system we chose was an amorphous Nb-Si alloy, because of the hope that in the long run we could make connection with our work on pure a-Si described above. Using deposition procedures similar to those we used for our very thin a-Si barriers, Nb/a-(Nb-Si)/Nb trilayers were formed and then patterned into junctions a few microns in diameter. Because of the very high resistances that we could achieve with these systems, we chose early in the program to explore the potential of our structures as high-resistance, sandwichtype Josephson junctions. A brief description of these devices and their electrical performance is contained in Ref. 15. A more complete description can be found in the thesis of Adrian Barrera, a visiting graduate student from the University of Mexico, who carried out the work [16]. These junctions readily yielded devices with resistances in the range of one ohm and I_cR products (a critical device figure of merit) of about 100 μ V. The critical currents of these devices exhibited classical, single-slit-like magnetic diffraction patterns. They also exhibited cavityinduced rf Josephson steps in their I-V characteristics at voltages corresponding to 100 GHz radiation. Thus they are capable of very high-frequency application. In addition to these device studies, the various basic physical parameters of the barrier were also measured. These included the magnitude and temperature dependence of the proximity effect coherence length of the a-(Nb-Si).

As stated in the introduction, these devices represent an important expansion of the types of Josephson devices that are now available for applications. They are most attractive in those applications where shunted tunnel junctions are currently used. In this case, an external shunt is used to eliminate the hysteresis normally present in the I-V curve of a tunneling Josephson junction. The price paid is the space required to form the shunt and the markedly reduced I_CR-product of the device. Our junctions have comparable

or better I_cR -products, even in their unoptimized form, and are very compact. They appear ideal for use in arrays of Josephson junctions of interest for local oscillator or variable series-connected JJ delay line applications. In the case of local oscillators, it is desirable to have all the junctions contained within one wavelength, and for variable delay transmission lines, several junctions per wavelength in order to avoid distributed effects in the operation of such devices.

Finally we note that our approach may be applicable to the new high-Tc oxide superconductors, with which tunneling junctions may not be possible.

V. Deposition of the New Oxide Superconductors in Thin Film Form

Right after the confirmation of high temperature superconductivity in (La-Sr)₂CuO₄ by the University of Tokyo group, we immediately began attempts to grow these new superconductors in thin film form. These materials present problems of film growth quite unlike those of conventional superconductors. First of all, they contain up to five metallic elements, plus oxygen. Second, being oxides, they require deposition in considerable background pressures of oxygen, which presents many new technical problems. To get around these problems, in our original approach we simply deposited the metallic elements in a sufficient background pressure of oxygen to form chemically-stable amorphous mixtures of the various oxides of the metals and then post-annealed the films in oxygen at high temperature to form the desired high temperature Perovskite oxide superconducting phase. If suitable substrates are used (e.g., SrTiO₃), the resultant film growth is in the form of polycrystalline epitaxial growth.

It was with this so-called post-annealed approach that we deposited the first thin films of these new superconductors. We then went on to more systematically study the materials science of these films, the utility of various substrates, and the effects of substrate temperature on the properties of the resultant films. A detailed account of this work can be found in Ref. 17. The post-annealed process has been extended to many of the other high-temperature oxide superconductors by other researchers and is now one of the standard approaches.

It became clear early on, however, that it would be very desirable to grow the materials directly at low temperatures and on a wider range of substrates. This has led to various attempts to grow films of these materials *in situ*. A nearly uncountable number of papers have now been published on this subject, most of which report the empirical results of deposition by this or that technique and under various conditions. In our work, we have focused on electron-beam reactive coevaporation, and on systematic studies aimed at establishing quantitatively the conditions necessary for successful film growth. In particular, we have explored the relative utility of various forms of reactive oxygen, including atomic oxygen, charged ions and ozone, in addition to molecular oxygen [18].

As a part of this work, we have developed various means of introducing these reactive oxygen species into our evaporation system and to measure quantitatively their fluxes at the substrate. At the same time, the presence of a high background pressure of oxygen has necessitated the development of new approaches to monitoring the rates of the metal fluxes. Most of the conventional approaches cannot be used in such high background pressures (e.g., ion gauge rate monitors) or when the metallic species in question is oxidized on the detector surface (e.g., crystal quartz monitors). To solve these problems, in collaboration with Xinix, Inc, we have been exploring the use of atomic absorption rate monitoring [19]. This approach has the distinct advantage of being species selective and therefore to first-order independent of the high oxygen background pressure. The main problem we have encountered in utilizing this technique is the construction of thermally-stable mechanical fixtures (in the presence of substrate heaters) needed to hold the optical fibers and collimate the transmit light used to monitor the evaporant flux.

VI. Physical Properties of Thin Films of the High-Temperature Superconductors.

Using the thin films described above, and some bulk crystals produced by other member of our group under other contracts, under this program we have carried out various studies of the physical properties of these new superconductors. One major theme has been tunneling studies of these materials. We have used point-contact tunneling, scanning-tunneling

microscopes (STM), and conventional sandwich-type tunnel junctions. Some of the major findings of this work are:

- (1) evidence for large energy gaps in these materials corresponding to values of $2\Delta/kTc = 6-7$. We were the first to report such large values, and subsequently many workers have reported similar results [20,21,22,23,24]. See Ref. 24 for a useful review of these results
- (2) observation of anomalous conductance in the normal state tunneling in these materials at bias voltages well above the suspected energy gap region and for temperatures above Tc [See Ref. 24].
- (3) STM images of the surface of 2212 BiSrCaCuO that showed the 27.2 Å superstructure present in these materials. This work also provided the first direct evidence that the superstructure was associated with the bismuth oxide layers in this material [25].

Because of the nontrivial materials problems presented by these materials, tunneling studies have tended to be controversial. Nonetheless, when the data from various studies are taken as a whole, the picture is much clearer. In Ref. 24 we undertook such a comprehensive look and concluded that there is considerable support for the large gaps we first reported in these materials, and that local tunneling probes seem more likely to see "clean" BCS-like tunneling characteristics.

We also used these films to study the critical current densities in these new superconductors. In the early days of the field, there was considerable concern over the very low critical current densities exhibited in bulk forms of the materials. Concurrently with work at IBM, we first showed that these superconductors could carry substantial critical currents, even at elevated temperatures [26]. This work provided a proof in principle that these materials could be used in high current applications. It remains true to this day that the best critical currents are obtained in these film samples. Part of the reason for this lies in their well-oriented microstructure—crucial in such anisotropic materials—but the origins of the high flux pinning, which must also be present, have not been identified.

In collaboration with the groups of John Clarke and Paul Richards at the University of California at Berkeley, we carried out studies of the noise properties of these films [27,28,29,30]. The work included flux noise relevant for SQUID applications and resistance fluctuations near Tc relevant for bolometer applications. This work clearly demonstrated the close connection between the noise and the perfection of the microstructure of the films. The noise performance distinctly improved as the degree of orientation of the grains improved, and was found to be low enough for applications when good *in situ* films were used. A proposal for a HTSC bolometer based on this work is described in Ref. 31. SQUID work at Berkeley is now underway based in part on the favorable prognosis provided by this work.

Other studies carried out on these films include measurements of the fluctuation conductivity above Tc and studies of the optical properties of these films. See complete list of publications.

REFERENCES

- 1. D.A. Rudman and M.R. Beasley, "Oxidized Amorphous-Silicon Superconducting Junction Barriers," *Appl. Phys. Lett.* **36**, 1010 (1980).
- 2. D.A. Rudman, F. Hellman, R.H. Hammond, and M.R. Beasley, "A15 Nb-Sn Tunnel Junction Fabrication and Properties," J. Appl. Phys. 55, p. 3544 (1984).
- 3. D.A. Rudman and M.R. Beasley, "Microscopic Superconducting Parameters from Tunneling in A15 Nb-Sn," *Phys. Rev. B* **30**, p. 2590 (1984).
- 4. D.A. Rudman, "A15 Niobium-Tin: Fabrication and Superconductive Tunneling Spectroscopy," PhD Thesis, Department of Electrical Engineering, Stanford University, 1982.
- 5. S. Bending, M.R. Beasley, and C.C. Tsuei, "Tunneling Study of Superconducting A15 V-Ga Films," *Phys. Rev. B* **30**, pp. 6342-6348 (1984).
- 6. A. Davidson, B. Dueholm, M.R. Beasley, "Experiments on Intrinsic and Thermally-Induced Chaos in an RF Driven Josephson Junction," *Phys. Rev. B* **33**, pp. 5127-5130 (April 1986).
- 7. S.J. Bending, "Tunneling and Transport via Localized States in Thin a-Si Tunnel Barriers and the Application of these Barriers in a Tunneling Study of Superconducting V-Ga Alloy Fims," PhD Thesis, Department of Applied Physics, Stanford University, 1985
- 8. M.R. Beasley, S. Bending, and J. Graybeal, "Preparation and Physics of Novel Microstructures for Localization Studies," in *Localization*, *Interaction*, and *Transport Phenomena*, eds. B. Kramer, G. Bergmann, and Y. Bruynseraede (Springer-Verlag, 1985); pp. 138-147.
- 9. S.J. Bending and M.R. Beasley, "Transport Processes via Localized States in Thin A-Si Tunnel Barriers," *Phys. Rev. Lett.* **55**, pp. 324-327 (July 1985).
- 10. R.R. Brynsvold, "Conductance, Conductance Fluctuations, and Low-Frequency Noise in Amorphous-Silicon-Barrier Tunnel Junctions," PhD Thesis, Department of Applied Physics, October 1985.
- 11. M. Naito and M.R. Beasley, "A Microscopic Study of Tunneling Processes via Localized States in Amorphous-Si/SiOx Tunnel Barriers," *Phys. Rev Lett.* **35**, pp. 2545-2551 (15 February 1987).

- 12. Y. Xu, A. Matsuda, and M.R. Beasley, "The Role of Inelastic Effects on Tunneling Via Localized States in Metal/Insulator/Metal Tunnel Junction," submitted to *Phys. Rev. Letters*.
- 13. L.I. Glazman and R.I. Shekhter, *Solid State Communications*, **66**, p. 65 (1988; *Sov. Phys. JETP* **67**, p. 163 (1988); and L.I. Glazman and K.A. Matveev, *Sov. Phys. JETP* **67**, p. 1376 (1988).
- 14. A. Matsuda, Y. Xu, and M.R. Beasley, to be published.
- 15. A.S. Barrera and M. R. Beasley, "High-Resistance SNS Sandwich-Type Josephson Junctions," *IEEE Trans. Magnetics* MAG-23, 868 (March 1987).
- 16. Adrian S. Barrera Roldan, "Uniones Josephson Tipo Emparedado con Barrera de (Nb-Si)-Amorto," PhD. Thesis, Universidad Nacional Autonoma de Mexico, May 1989.
- 17. E.S. Hellman, D.G. Schlom, N. Missert, K. Char, J.S. Harris, Jr., M.R. Beasley, A.Kapitulnik, and T.H. Geballe (Stanford), J.N. Eckstein, S.-L. Weng, and C. Webb (Varian) "Molecular Beam Epitaxy and Deposition of High-T_C Superconductors," J. Vac. Sci. & Tech. **B6**, 799-803 (Mar/Apr. 1988).
- 18. N. Missert, P. Rosenthal, B. Oh, S. Spielman, A. Marshall, R. Barton, M.R. Beasley, T.H. Geballe, R.H. Hammond and A. Kapitulnik, "In situ Growth of Superconducting YBaCuO Using Reactive Electron-Beam Coevaporation," IEEE Trans. on Magnt. MAG-25, 2418-2421, March 1989.
- 19. C. Lu (Xinix), N. Missert, J.E. Mooij, P. Rosenthal, V. Matijasevic, M.R. Beasley, and R.H. Hammond (Stanford), "Rate and Composition Control by Atomic Absorption Spectroscopy for the Coevaporation of High Tc Superconducting Films," presented at 35th National Symposium of the American Vacuum Society, Atlanta, GA. October 3-7, 1988.
- 20. M.D. Kirk, D.P.E. Smith, D.B. Mitzi, J.Z. Sun, D.J. Webb, K. Char, M.R. Hahn, M. Naito, B. Oh, M.R. Beasley, T.H. Geballe, R.H. Hammond, A. Kapitulnik, and C.F. Quate, "Point-Contact Electron Tunneling into the High-Tc Superconductor YBaCuO," *Phys. Rev. B* 35, pp. 8850-8852 (June 1987).
- 21. M.R. Beasley, "Synthesis and Properties of Thin Film High-T_C Oxide Superconductors," presented at Yamada Conference XVIII on Superconductivity in Highly Correlated Fermion Systems (invited paper), Sendai, Japan, August 31-September 3, 1987; Physica 148B (North-Holland, 1987) pp. 191-195.

- 22. Mark Lee, M. Naito, A. Kapitulnik, and M.R. Beasley, "Systematic Effects in Thin Film Tunnel Junctions of YBa₂Cu₃O_{7-d}," Solid State Comm.. 17, No. 4, 449-452 (April 1989)
- 23. Mark Lee, D.B. Mitzi, A. Kapitulnik, and M.R. Beasley, "Electron Tunneling and the Energy Gap in Bi₂Sr₂CaCu₂O_x," *Phys. Rev. B.* **39**, 801–803 (1 January 1989).
- 24. Mark Lee, A. Kapitulnik, and M.R. Beasley, "Tunneling and the Energy Gap in the High-Temperature Superconductors," in *Mechanisms of High Temperature Superconductivity*, eds. Kamimura and Oshiyama (Springer-Verlag, Berlin, 1989), pp. 220-228.
- 25. M.D. Kirk, C.B. Eom, B, Oh, S. Spielman, M.R. Beasley, A. Kapitulnik, T.H. Geballe, and C.F. Quate, "Scanning Tunneling Microscopy of the A-B Planes of Bi₂(Ca,Sr)₃Cu₂O_{8+∂} Single Crystal and Thin Film," *Appl. Phys. Lett.* **52**, 2071-2073 (June 1988).
- 26. B. Oh, M. Naito, S. Arnason, P. Rosenthal, R. Barton, M.R. Beasley, T.H. Geballe, R.H. Hammond, and A. Kapitulnik, "Critical Current Densities and Transport in Superconducting YBa₂Cu₃O_{7-∂} Films Made by E-Beam Evaporation," Applied Physics Letters 51, 852-854 (14 September 1987).
- 27. M.J. Ferrari, Mark Johnson, F.C. Wellstood, and John Clarke (U.C. Berkeley); P.A. Rosenthal, R.H. Hammond, and M.R. Beasley (Stanford), "Magnetic Flux Noise in Thin Film Rings of YBa₂Cu₃O_{7-∂}," Applied Phys. Lett. **53**, 695-697, 22 August, 1988.
- P. Rosenthal, R.H. Hammond, and M.R. Beasley (Stanford), R. Leoni, Ph. Lerch, and J. Clarke (U.C.Berkeley), "Low Frequency Resistance Fluctuations in Films of High Temperature Superconductors," *IEEE Trans. on Magnt.* MAG-25, 973-975, March 1989.
- 29. M.J. Ferrari, M. Johnson, F.C. Wellstood, J. Clarke (U.C. Berkeley and Lawrence Berkeley Lab), P. Rosenthal, R. Hammond, M.R. Beasley (Stanford), "Flux Noise and Flux Creep in YBCO Thin Films," *IEEE Trans. on Magnt.* MAG-25, 806-809, March 1989.
- 30. M.J. Ferrari, Mark Johnson, Frederick C. Wellstood and John Clarke (Berkeley), D. Mitzi, P.A. Rosenthal, C.B. Eom, T.H. Geballe, A. Kapitulnik, and M.R. Beasley (Stanford), "Distribution of Flux Pinning Energies in YBa₂Cu₃O_{7-d} and Bi₂Sr₂CaCu₂O_{8+d} from Flux Noise," submitted to Phys. Rev. Lett.
- 31. P.I. Richards, J. Clarke, R. Leoni, Ph. Lerch, S. Verghese (Berkeley), and M.R. Beasley, T.H. Geballe, R.H. Hammond, P. Rosenthal, S.R. Spielman (Stanford), "Feasibility of the High Tc Superconducting Bolometer," *Appl. Phys. Lett.* **54**, 283-285 (16 January 1989).

ONR-Supported Publications under Contract N00014-83-K-0391

- 1. S. Bending, M.R. Beasley, and C.C. Tsuei, "Tunneling Study of Superconducting A15 V-Ga Films," *Phys. Rev. B* **30**, pp. 6342-6348 (1984).
- 2. D.A. Rudman, F. Hellman, R.H. Hammond, and M.R. Beasley, "A15 Nb-Sn Tunnel Junction Fabrication and Properties," J. Appl. Phys. 55, p. 3544 (1984).
- 3. D.A. Rudman and M.R. Beasley, "Microscopic Superconducting Parameters from Tunneling in A15 Nb-Sn," *Phys. Rev. B* **30**, p. 2590 (1984).
- 4. S.J. Bending, R.H. Hammond, and M.R. Beasley, "Superconductivity in the High-T_C A15 V-6a System," *Bull. Am. Phys. Soc.* **29**, p. 385 (1984).
- 5. M. Tinkham, M.R. Beasley, D.C. Larbalestier, A.F. Clark, and D.K. Finnemore, "Research Opportunities in Superconductivity," *Cryogenics*, p. 378 (1984).
- 6. M.R. Beasley, S. Bending, and J. Graybeal, "Preparation and Physics of Novel Microstructures for Localization Studies," in *Localization, Interaction, and Transport Phenomena*, eds. B. Kramer, G. Bergmann, and Y. Bruynseraede (Springer-Verlag, 1985); pp. 138-147.
- 7. M.R. Beasley and T.H. Geballe, "Superconducting Materials," *Physics Today*, pp. 60-68 (Oct. 1984).
- 8. S.J. Bending and M.R. Beasley, "Transport Processes via Localized States in Thin A-Si Tunnel Barriers," *Phys. Rev. Lett.* **55**, pp. 324-327 (July 1985).
- 9. S. Bending, R. Brynsvold, and M.R. Beasley, "Role of Localized States in Amorphous Silicon Tunnel Barriers," presented at ICMC Conference, Cambridge, MA, August 12-16, 1985. To appear in *Advances in Cryogenic Engineering*, 32 (Plenum Press).
- 10. M. Naito and M.R. Beasley, "A Microscopic Study of Tunneling Processes via Localized States in Amorphous-Si/SiOx Tunnel Barriers," *Phys. Rev Lett.* **35**, pp. 2545-2551 (15 February 1987).
- 11. A.S. Barrera and M. R. Beasley, "High-Resistance SNS Sandwich-Type Josephson Junctions," *IEEE Trans. Magnetics* MAG-23, 868 (March 1987).

- J.Z. Sun, D.J. Webb, M. Naito, K. Char, M.R. Hahn, J.W.P. Hsu, A.D. Kent, D.B. Mitzi, B. Oh, M.R. Beasley, T.H. Geballe, R.H. Hammond, and A. Kapitulnik, "Superconductivity and Magnetism in the High T_C Superconductor YBaCuO," *Phys. Rev. Lett.* 58, 1574-1576 (April 1987).
- 13. M.D. Kirk, D.P.E. Smith, D.B. Mitzi, J.Z. Sun, D.J. Webb, K. Char, M.R. Hahn, M. Naito, B. Oh, M.R. Beasley, T.H. Geballe, R.H. Hammond, A. Kapitulnik, and C.F. Quate, "Point-Contact Electron Tunneling into the High-Tc Superconductor YBaCuO," *Phys. Rev. B* 35, pp. 8850-8852 (June 1987).
- M. Naito, D.P.E. Smith, M.D. Kirk, B. Oh, M.R. Hahn, K. Char, D.B. Mitzi, J.Z. Sun, D.J. Webb, M.R. Beasley, O. Fischer, T.H. Geballe, R.H. Hammond, A. Kapitulnik, and C.F. Quate, "Electron Tunneling Studies into Thin Films of High-T_C Superconducting LaSrCuO," *Phys. Rev. B* 35, 7228-7237 (May 1987).
- 15. R.H. Hammond, M. Naito, B. Oh, M. Hahn, P. Rosenthal, A. Marshall, N. Missert, M.R. Beasley, A. Kapitulnik, and T.H. Geballe, "Superconducting Thin Films of the Perovskite Superconductors by Electron-Beam Deposition," to appear in Extended Abstracts for MRS Symposium on HighTemperature Superconductors, Anaheim, California, April 23-24, 1987.
- 16. T.H. Geballe, A. Kapitulnik, M.R. Beasley, R.H. Hammond, D.J. Webb, D.B. Mitzi, J.Z. Sun, A.D. Kent, J.W.P. Hsu, and S. Arnason (Stanford); M.I. Gusman, D.L. Hildenbrand, S.M. Johnson, M.A. Quinlan, and D.J. Rowcliffe (SRI International), "Some Thoughts about the High T_C Perovskite Superconductors," to appear in Extended Abstracts for MRS Symposium on High Temperature Superconductors, Anaheim, California, April 23-24, 1987.
- 17. M. Naito, R.H. Hammond, B. Oh, M.R. Hahn, J.W.P. Hsu, P. Rosenthal, A.F. Marshall, M.R. Beasley, T.H. Geballe, and A. Kapitulnik, "Thin Film Synthesis of the High-T_c Oxide Superconductor YBa₂Cu₃O₇ by Electron Beam Codeposition," J. Mat. Res. 2, 713-725 (Nov/Dec. 1987).
- 18. B. Oh, M. Naito, S. Arnason, P. Rosenthal, R. Barton, M.R. Beasley, T.H. Geballe, R.H. Hammond, and A. Kapitulnik, "Critical Current Densities and Transport in Superconducting YBa₂Cu₃O_{7-∂} Films Made by E-Beam Evaporation," Applied Physics Letters 51, 852-854 (14 September 1987).
- 19. A. Kapitulnik, B.Oh, M. Naito, K. Char, A.D. Kent, N. Missert, E. Hellman, S. Arnason, J.W.P. Hsu, M.R. Hahn, P. Rosenthal, R. Barton, M.R. Beasley, T.H. Geballe, and R.H. Hammond, "Superconducting Properties of Thin Films of the High-Tc Perovskite Superconductors," to be published in Proceedings of "High-Tc Superconductors," ICTP, Trieste, Italy, July 1987, World Scientific Publishing, Inc.

- 20. M.R. Beasley, "Synthesis and Properties of Thin Film High-T_C Oxide Superconductors," presented at Yamada Conference XVIII on Superconductivity in Highly Correlated Fermion Systems (invited paper), Sendai, Japan, August 31-September 3, 1987; *Physica* 148B (North-Holland, 1987) pp. 191-195.
- 21. I. Bosovic, D. Kirillov, A. Kapitulnik, K. Char, M.R. Hahn, M.R. Beasley, T.H. Geballe, T.H. Kim, and A.J. Heeger, "Optical Measurements on Oriented Thin YBa₂Cu₃O_{7-∂} Films: Lack of Evidence for Excitonic Superconductivity," *Phys. Rev. Lett.* **59**, 2219-2221 (Nov. 9, 1987).
- 22. M.R. Beasley, "The Revolution in High Tc Superconductivity—Status and Prospects for Electronic Applications," presented at 1987 IEEE International Electron Devices Meeting, Washington, D.C. December 6-9, 1987 (Invited). In Technical Digest.
- 23. B. Oh, K. Char, A.D. Kent, M. Naito, M.R. Beasley, T.H. Geballe, R.H. Hammond, A. Kapitulnik (Stanford), J.M. Graybeal (MIT), "Upper Critical Field, Fluctuation Conductivity, and Dimensionality of Y₁Ba₂Cu₃O_{7-x}," *Phys. Rev. B.* **37**, 7861-7864 (May 1, 1988).
- 24. I. Bozovic, D. Mitzi, M. Beasley, A.Kapitulnik, T.Geballe (Stanford University), and S. Perkowitz, G.L. Carr, B. Lou, R. Sudharsanan, and S.S. Yom (Emory University), "Vibrational Spectra and Lattice Instabilities in the High-Tc Superconductors YBa₂Cu₃O₇ and GdBa₂Cu₃O₇," *Physical Review B* 36, pp. 4000-4002, (1 Sept. 1987).
- 25. A.F. Marshall, B. Oh, S. Spielman, Mark Lee, C.B. Eom, R.W. Barton, R.H. Hammond, A. Kapitulnik, M.R. Beasley, and T.H. Geballe, "Two-dimensional Superstructure in the A-B Plane of Bi₂(Ca,Sr)₃Cu₂O_{8+∂} Thin Films," *Appl. Phys. Lett.* 53, 426–428 (August 1988).
- 26. M.D. Kirk, C.B. Eom, B, Oh, S. Spielman, M.R. Beasley, A. Kapitulnik, T.H. Geballe, and C.F. Quate, "Scanning Tunneling Microscopy of the A-B Planes of Bi₂(Ca,Sr)₃Cu₂O_{8+∂} Single Crystal and Thin Film," *Appl. Phys. Lett.* **52**, 2071-2073 (June 1988).
- 27. M.J. Ferrari, Mark Johnson, F.C. Wellstood, and John Clarke (U.C. Berkeley); P.A. Rosenthal, R.H. Hammond, and M.R. Beasley (Stanford), "Magnetic Flux Noise in Thin Film Rings of YBa₂Cu₃O_{7-∂}," Applied Phys. Lett. 53, 695-697, 22 August, 1988.
- 28. Mark Lee, M. Naito, A. Kapitulnik, and M.R. Beasley, "Systematic Effects in Thin Film Tunnel Junctions of YBa₂Cu₃O_{7-d}," Solid State Comm.. 17, No. 4, 449-452 (April 1989)
- 29. Mark Lee, D.B. Mitzi, A. Kapitulnik, and M.R. Beasley, "Electron Tunneling and the Energy Gap in Bi₂Sr₂CaCu₂O_x," Phys. Rev. B. **39**, 801–803 (1 January 1989).

- 30. P. Rosenthal, R.H. Hammond, and M.R. Beasley (Stanford), R. Leoni, Ph. Lerch, and J. Clarke (U.C.Berkeley), "Low Frequency Resistance Fluctuations in Films of High Temperature Superconductors," *IEEE Trans. on Magnt.* MAG-25, 973-975, March 1989.
- 31. M.J. Ferrari, M. Johnson, F.C. Wellstood, J. Clarke (U.C. Berkeley and Lawrence Berkeley Lab), P. Rosenthal, R. Hammond, M.R. Beasley (Stanford), "Flux Noise and Flux Creep in YBCO Thin Films," *IEEE Trans. on Magnt.* MAG-25, 806-809, March 1989.
- 32. N. Missert, P. Rosenthal, B. Oh, S. Spielman, A. Marshall, R. Barton, M.R. Beasley, T.H. Geballe, R.H. Hammond and A. Kapitulnik, "In situ Growth of Superconducting YBaCuO Using Reactive Electron-Beam Coevaporation," IEEE Trans. on Magnt. MAG-25, 2418-2421, March 1989
- 33. P.L. Richards, J. Clarke, R. Leoni, Ph. Lerch, S. Verghese (Berkeley), and M.R. Beasley, T.H. Geballe, R.H. Hammond, P. Rosenthal, S.R. Spielman (Stanford), "Feasibility of the High Tc Superconducting Bolometer," *Appl. Phys. Lett.* **54**, 283-285 (16 January 1989).
- 34. Mark Lee, A. Kapitulnik, and M.R. Beasley, "Tunneling and the Energy Gap in the High-Temperature Superconductors," in *Mechanisms of High Temperature Superconductivity*, eds. Kamimura and Oshiyama (Springer-Verlag, Berlin, 1989), pp. 220-228.
- 35. C. Lu (Xinix), N. Missert, J.E. Mooij, P. Rosenthal, V. Matijasevic, M.R. Beasley, and R.H. Hammond (Stanford), "Rate and Composition Control by Atomic Absorption Spectroscopy for the Coevaporation of High Tc Superconducting Films," presented at 35th National Symposium of the American Vacuum Society, Atlanta, GA. October 3-7, 1988.
- 36. M.R. Beasley, "Advances in the Fabrication of High-Temperature Superconductors," Physics News in 1988, *Physics Today*, pp. 23-25, January 1989.
- 37. M.R. Beasley, "High-Temperature Superconductive Thin Films," (invited), *IEEE Proceedings* 77, pp.1155-1163 (August 1989).
- 38. Shuichi Tahara, S.M. Anlage, Chang-Beom Eom, D.K. Fork, T.H. Geballe, M.R. Beasley, "Critical Current Behavior in Narrow YBa₂Cu₃O_{7-d} Thin Films," presented at International Conference on Materials and Mechanisms of Superconductivity: High-Temperature Superconductors, Stanford University, July 23-28, 1989. To appear in the *Proceedings* (North-Holland, 1989).

- 39. M.J. Ferrari, Mark Johnson, Frederick C. Wellstood and John Clarke (Berkeley), D. Mitzi, P.A. Rosenthal, C.B. Eom, T.H. Geballe, A. Kapitulnik, and M.R. Beasley (Stanford), "Distribution of Flux Pinning Energies in YBa₂Cu₃O_{7-d} and Bi₂Sr₂CaCu₂O_{8+d} from Flux Noise," submitted to Phys. Rev. Lett.
- 40. Shuichi Tahara, Steven M. Anlage, J. Halbritter, Chang-Beom Eom, D.K. Fork, T.H. Geballe, and M.R. Beasley, "Critical Currents, Pinning and Edge Barriers in Narrow YBa₂Cu₃O_{7-d} Thin Films," submitted to *Phys. Rev. B*.